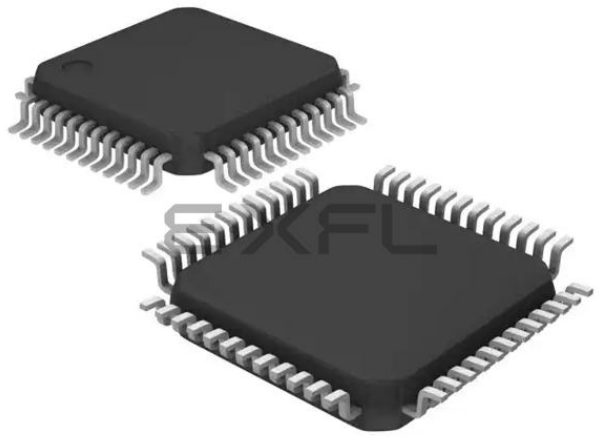

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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "Embedded - Microcontrollers"

Details	
Product Status	Active
Core Processor	56800EX
Core Size	32-Bit Single-Core
Speed	100MHz
Connectivity	CANbus, I²C, SCI, SPI
Peripherals	DMA, POR, PWM, WDT
Number of I/O	39
Program Memory Size	64KB (32K x 16)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	4K x 16
Voltage - Supply (Vcc/Vdd)	2.7V ~ 3.6V
Data Converters	A/D 10x12b; D/A 2x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	48-LQFP
Supplier Device Package	48-LQFP (7x7)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mc56f82746vlf

Table 1. MC56F827xx Family (continued)

Feature	MC56F82											
Part Number[1]	748V LH	746V LF 746M LF	743V LC	743V FM	738V LH	736V LF	733V LC	733V FM 733M FM	728V LH	726V LF	723V LC	723V FM
Analog Comparators (CMP)	4	4	3	3	4	4	3	3	4	4	3	3
QSCI	2	2	1	1	2	2	1	1	2	2	1	1
QSPI	2	1	1	1	2	1	1	1	2	1	1	1
I2C/SMBus	1	1	1	1	1	1	1	1	1	1	1	1
MSCAN	1	1	0	0	1	1	0	0	1	1	0	0
GPIO	54	39	26	26	54	39	26	26	54	39	26	26
Package pin count	64 LQFP	48 LQFP	32 LQFP	32 QFN	64 LQFP	48 LQFP	32 LQFP	32 QFN	64 LQFP	48 LQFP	32 LQFP	32 QFN
AEC-Q100[3]	Yes	Yes	No	No	Yes	Yes	No	No	Yes	Yes	No	No

1. Temperature options
   V: -40°C to 105°C
   M: -40°C to 125°C
2. Input capture shares the pin with cooresponding PWM channels.
3. Qualification aligned to AEC-Q100

1.2 56800EX 32-bit Digital Signal Controller (DSC) core

- Efficient 32-bit 56800EX Digital Signal Processor (DSP) engine with modified dual Harvard architecture:
  - Three internal address buses
  - Four internal data buses: two 32-bit primary buses, one 16-bit secondary data bus, and one 16-bit instruction bus
  - 32-bit data accesses
  - Supports concurrent instruction fetches in the same cycle, and dual data accesses in the same cycle
  - 20 addressing modes
- As many as 100 million instructions per second (MIPS) at 100 MHz core frequency
- 162 basic instructions
- Instruction set supports both fractional arithmetic and integer arithmetic
- 32-bit internal primary data buses support 8-bit, 16-bit, and 32-bit data movement, plus addition, subtraction, and logical operations
- Single-cycle 16 × 16-bit -> 32-bit and 32 x 32-bit -> 64-bit multiplier-accumulator (MAC) with dual parallel moves
- 32-bit arithmetic and logic multi-bit shifter
- Four 36-bit accumulators, including extension bits

- Automatic mode allows the DAC to automatically generate pre-programmed output waveforms, including square, triangle, and sawtooth waveforms (for applications like slope compensation)
- Programmable period, update rate, and range
- Output can be routed to an internal comparator, ADC, or optionally to an off-chip destination

1.6.7 Quad Timer

- Four 16-bit up/down counters, with a programmable prescaler for each counter
- Operation modes: edge count, gated count, signed count, capture, compare, PWM, signal shot, single pulse, pulse string, cascaded, quadrature decode
- Programmable input filter
- Counting start can be synchronized across counters
- Up to 100 MHz operation clock

1.6.8 Queued Serial Communications Interface (QSCI) modules

- Operating clock can be up to two times the CPU operating frequency
- Four-word-deep FIFOs available on both transmit and receive buffers
- Standard mark/space non-return-to-zero (NRZ) format
- 16-bit integer and 3-bit fractional baud rate selection
- Full-duplex or single-wire operation
- Programmable 8-bit or 9-bit data format
- Error detection capability
- Two receiver wakeup methods:
  - Idle line
  - Address mark
- 1/16 bit-time noise detection
- Up to 6.25 Mbit/s baud rate at 100 MHz operation clock

1.6.9 Queued Serial Peripheral Interface (QSPI) modules

- Maximum 12.5 Mbit/s baud rate
- Selectable baud rate clock sources for low baud rate communication
- Baud rate as low as Baudrate_Freq_in / 8192
- Full-duplex operation
- Master and slave modes
- Double-buffered operation with separate transmit and receive registers
- Four-word-deep FIFOs available on transmit and receive buffers

1.6.16 Clock sources

1.6.16.1 On-chip oscillators

- Tunable 8 MHz relaxation oscillator with 400 kHz at standby mode (divide-by-two output)
- 200 kHz low frequency clock as secondary clock source for COP, EWM, PIT

1.6.16.2 Crystal oscillator

- Support for both high ESR crystal oscillator (ESR greater than 100 Ω) and ceramic resonator
- Operating frequency: 4–16 MHz

1.6.17 Cyclic Redundancy Check (CRC) Generator

- Hardware CRC generator circuit with 16-bit shift register
- High-speed hardware CRC calculation
- Programmable initial seed value
- CRC16-CCITT compliancy with $x^{16} + x^{12} + x^5 + 1$ polynomial
- Error detection for all single, double, odd, and most multibit errors
- Option to transpose input data or output data (CRC result) bitwise, which is required for certain CRC standards

1.6.18 General Purpose I/O (GPIO)

- 5 V tolerance (except RESETB pin)
- Individual control of peripheral mode or GPIO mode for each pin
- Programmable push-pull or open drain output
- Configurable pullup or pulldown on all input pins
- All pins (except JTAG and RESETB) default to be GPIO inputs
- 2 mA / 9 mA source/sink capability
- Controllable output slew rate

1.7 Block diagrams

The 56800EX core is based on a modified dual Harvard-style architecture, consisting of three execution units operating in parallel, and allowing as many as six operations per instruction cycle. The MCU-style programming model and optimized instruction set

enable straightforward generation of efficient and compact code for the DSP and control functions. The instruction set is also efficient for C compilers, to enable rapid development of optimized control applications.

The device's basic architecture appears in Figure 1 and Figure 2. Figure 1 shows how the 56800EX system buses communicate with internal memories, and the IPBus interface and the internal connections among the units of the 56800EX core. Figure 2 shows the peripherals and control blocks connected to the IPBus bridge. See the specific device's Reference Manual for details.

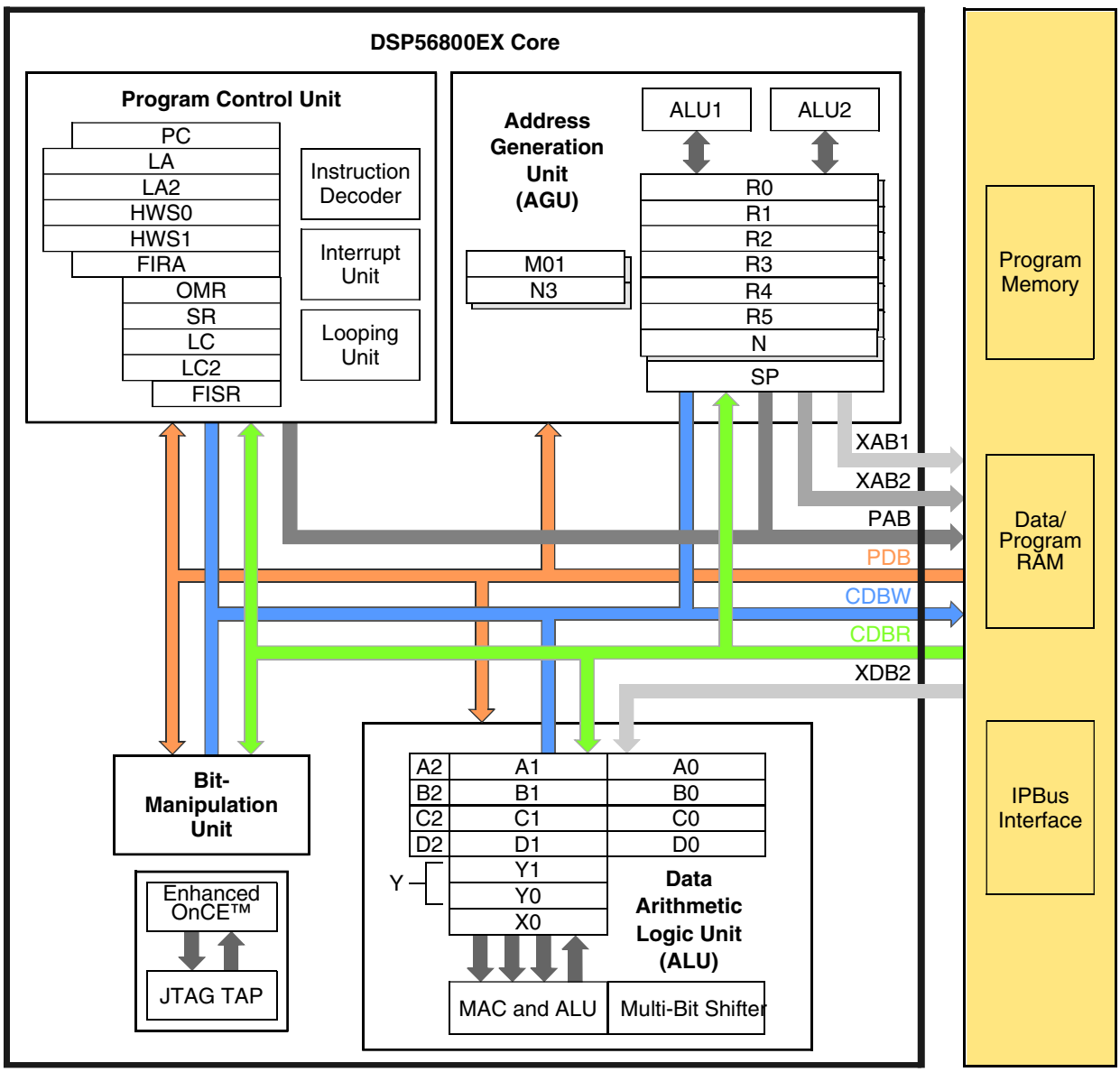


Figure 1. 56800EX basic block diagram

Table 2. Signal descriptions (continued)

Signal Name	64 LQFP	48 LQFP	32 LQFP	Type	State During Reset	Signal Description
TCK	1	1	1	Input	Input, internal pullup enabled	Test Clock Input — The pin is connected internally to a pullup resistor. A Schmitt-trigger input is used for noise immunity. After reset, the default state is TCK
(GPIOD2)				Input/Output		GPIO Port D2
TMS	63	47	31	Input	Input, internal pullup enabled	Test Mode Select Input — It is sampled on the rising edge of TCK and has an internal pullup resistor. After reset, the default state is TMS. **NOTE:** Always tie the TMS pin to V_{DD} through a 2.2 kΩ resistor if need to keep on-board debug capability. Otherwise, directly tie to V_{DD}.
(GPIOD3)				Input/Output		GPIO Port D3
$\overline{\text{RESET}}$ or RESETB	2	2	2	Input	Input, internal pullup enabled	Reset — A direct hardware reset on the processor. When $\overline{\text{RESET}}$ is asserted low, the device is initialized and placed in the reset state. A Schmitt-trigger input is used for noise immunity. The internal reset signal is deasserted synchronous with the internal clocks after a fixed number of internal clocks. After reset, the default state is $\overline{\text{RESET}}$. Recommended a capacitor of up to 0.1 µF for filtering noise.
(GPIOD4)				Input/ Opendrain Output		GPIO Port D4 $\overline{\text{RESET}}$ functionality is disabled in this mode and the device can be reset only through POR, COP reset, or software reset.
GPIOA0	13	9	6	Input/Output	Input, internal pullup enabled	GPIO Port A0
(ANA0&CMPA_IN3)				Input		ANA0 is analog input to channel 0 of ADCA; CMPA_IN3 is positive input 3 of analog comparator A. After reset, the default state is GPIOA0.
(CMPC_O)				Output		Analog comparator C output
GPIOA1	14	10	7	Input/Output	Input, internal pullup enabled	GPIO Port A1: After reset, the default state is GPIOA1.
(ANA1&CMPA_IN0)				Input		ANA1 is analog input to channel 1 of ADCA; CMPA_IN0 is negative input 0 of analog comparator A. When used as an analog input, the signal goes to ANA1 and CMPA_IN0. The ADC control register configures this input as ANA1 or CMPA_IN0.
GPIOA2	15	11	8	Input/Output	Input, internal pullup enabled	GPIO Port A2: After reset, the default state is GPIOA2.
(ANA2&VREFHA &CMPA_IN1)				Input		ANA2 is analog input to channel 2 of ADCA; VREFHA is analog reference

Table continues on the next page...

Table 2. Signal descriptions (continued)

Signal Name	64 LQFP	48 LQFP	32 LQFP	Type	State During Reset	Signal Description
DACB_O				Analog Output		12-bit digital-to-analog output
GPIOB2	27	20	13	Input/Output	Input, internal pullup enabled	GPIO Port B2: After reset, the default state is GPIOB2.
(ANB2&VERFHB &CMPC_IN3)				Input		ANB2 is analog input to channel 2 of ADCB; VREFHB is analog reference high of ADCB; CMPC_IN3 is positive input 3 of analog comparator C. When used as an analog input, the signal goes to both ANB2 and CMPC_IN3.
GPIOB3	28	21	—	Input/Output	Input, internal pullup enabled	GPIO Port B3: After reset, the default state is GPIOB3.
(ANB3&VREFLB& CMPC_IN0)				Input		ANB3 is analog input to channel 3 of ADCB; VREFLB is analog reference low of ADCB; CMPC_IN0 is negative input 0 of analog comparator C.
GPIOB4	21	14	—	Input/Output	Input, internal pullup enabled	GPIO Port B4: After reset, the default state is GPIOB4.
(ANB4&CMPC_IN 1)				Input		ANB4 is analog input to channel 4 of ADCB; CMPC_IN1 is negative input 1 of analog comparator C.
GPIOB5	20	—	—	Input/Output	Input, internal pullup enabled	GPIO Port B5: After reset, the default state is GPIOB5.
(ANB5&CMPC_IN 2)				Input		ANB5 is analog input to channel 5 of ADCB; CMPC_IN2 is negative input 2 of analog comparator C.
GPIOB6	19	—	—	Input/Output	Input, internal pullup enabled	GPIO Port B6: After reset, the default state is GPIOB6.
(ANB6&CMPB_IN 1)				Input		ANB6 is analog input to channel 6 of ADCB; CMPB_IN1 is negative input 1 of analog comparator B.
GPIOB7	17	—	—	Input/Output	Input, internal pullup enabled	GPIO Port B7: After reset, the default state is GPIOB7.
(ANB7&CMPB_IN 2)				Input		ANB7 is analog input to channel 7 of ADCB; CMPB_IN2 is negative input 2 of analog comparator B.
GPIOC0	3	3	—	Input/Output	Input, internal pullup enabled	GPIO Port C0: After reset, the default state is GPIOC0.
(EXTAL)				Analog Input		The external crystal oscillator input (EXTAL) connects the internal crystal oscillator input to an external crystal or ceramic resonator.
(CLKIN0)				Input		External clock input 0[1]
GPIOC1	4	4	—	Input/Output	Input, internal pullup enabled	GPIO Port C1: After reset, the default state is GPIOC1.
(XTAL)				Input		The external crystal oscillator output (XTAL) connects the internal crystal

Table continues on the next page...

Table 2. Signal descriptions (continued)

Signal Name	64 LQFP	48 LQFP	32 LQFP	Type	State During Reset	Signal Description
GPIOE4	51	39	25	Input/Output	Input, internal pullup enabled	GPIO Port E4: After reset, the default state is GPIOE4.
(PWMA_2B)				Input/Output		PWM module A (NanoEdge), submodule 2, output B or input capture B
(XB_IN2)				Input		Crossbar module input 2
GPIOE5	52	40	26	Input/Output	Input, internal pullup enabled	GPIO Port E5: After reset, the default state is GPIOE5.
(PWMA_2A)				Input/Output		PWM module A (NanoEdge), submodule 2, output A or input capture A
(XB_IN3)				Input		Crossbar module input 3
GPIOE6	53	—	—	Input/Output	Input, internal pullup enabled	GPIO Port E6: After reset, the default state is GPIOE6.
(PWMA_3B)				Input/Output		PWM module A (NanoEdge), submodule 3, output B or input capture B
(XB_IN4)				Input		Crossbar module input 4
GPIOE7	54	—	—	Input/Output	Input, internal pullup enabled	GPIO Port E7: After reset, the default state is GPIOE7.
(PWMA_3A)				Input/Output		PWM module A (NanoEdge), submodule 3, output A or input capture A
(XB_IN5)				Input		Crossbar module input 5
GPIOF0	36	28	—	Input/Output	Input, internal pullup enabled	GPIO Port F0: After reset, the default state is GPIOF0.
(XB_IN6)				Input		Crossbar module input 6
(SCLK1)				Input/Output		SPI1 serial clock — In master mode, SCLK1 pin is an output, clocking slaved listeners. In slave mode, SCLK1 pin is the data clock input 0.
GPIOF1	50	38	—	Input/Output	Input, internal pullup enabled	GPIO Port F1: After reset, the default state is GPIOF1.
(CLKO1)				Output		Buffered clock output 1: the clock source is selected by clockout select (CLKOSEL) bits in the clock output select register (CLKOUT) of the SIM.
(XB_IN7)				Input		Crossbar module input 7
(CMPD_O)				Output		Analog comparator D output
GPIOF2	39	—	19	Input/Output	Input, internal pullup enabled	GPIO Port F2: After reset, the default state is GPIOF2.
(SCL0)				Input/Open-drain Output		I^2C0 serial clock
(XB_OUT6)				Output		Crossbar module output 6
(MISO1)				Input/Output		Master in/slave out for SPI1 —In master mode, MISO1 pin is the data input. In slave mode, MISO1 pin is the data output. The MISO line of a slave device

Table continues on the next page...

Table 2. Signal descriptions (continued)

Signal Name	64 LQFP	48 LQFP	32 LQFP	Type	State During Reset	Signal Description
						is placed in the high-impedance state if the slave device is not selected.
GPIOF3	40	—	20	Input/Output	Input, internal pullup enabled	GPIO Port F3: After reset, the default state is GPIOF3.
(SDA0)				Input/Open-drain Output		I^2C0 serial data line
(XB_OUT7)				Output		Crossbar module output 7
(MOSI1)				Input/Output		Master out/slave in for SPI1— In master mode, MOSI1 pin is the data output. In slave mode, MOSI1 pin is the data input.
GPIOF4	41	—	—	Input/Output	Input, internal pullup enabled	GPIO Port F4: After reset, the default state is GPIOF4.
(TXD1)				Output		SCI1 transmit data output or transmit/ receive in single wire operation
(XB_OUT8)				Output		Crossbar module output 8
(PWMA_0X)				Input/Output		PWM module A (NanoEdge), submodule 0, output X or input capture X
(PWMA_FAULT6)				Input		Disable PWMA output 6
GPIOF5	42	—	—	Input/Output	Input, internal pullup enabled	GPIO Port F5: After reset, the default state is GPIOF5.
(RXD1)				Input		SCI1 receive data input
(XB_OUT9)				Output		Crossbar module output 9
(PWMA_1X)				Input/Output		PWM module A (NanoEdge), submodule 1, output X or input capture X
(PWMA_FAULT7)				Input		Disable PWMA output 7
GPIOF6	58	—	—	Input/Output	Input, internal pullup enabled	GPIO Port F6: After reset, the default state is GPIOF6.
(PWMA_3X)				Input/Output		PWM module A (NanoEdge), submodule 3, output X or input capture X
(XB_IN2)				Input		Crossbar module input 2
GPIOF7	59	—	—	Input/Output	Input, internal pullup enabled	GPIO Port F7: After reset, the default state is GPIOF7.
(CMPC_O)				Output		Analog comparator C output
(SS1_B)				Input/Output		In slave mode, SS1_B indicates to the SPI1 module that the current transfer is to be received.
(XB_IN3)				Input		Crossbar module input 3
GPIOF8	6	—	—	Input/Output	Input, internal pullup enabled	GPIO Port F8: After reset, the default state is GPIOF8.
(RXD0)				Input		SCI0 receive data input
(XB_OUT10)				Output		Crossbar module output 10
(CMPD_O)				Output		Analog comparator D output
(PWMA_2X)						PWM module A (NanoEdge), submodule 2, output X or input capture X

5.3.1 Example

This is an example of an attribute:

Symbol	Description	Min.	Max.	Unit
CIN_D	Input capacitance: digital pins	—	7	pF

5.4 Definition: Rating

A *rating* is a minimum or maximum value of a technical characteristic that, if exceeded, may cause permanent chip failure:

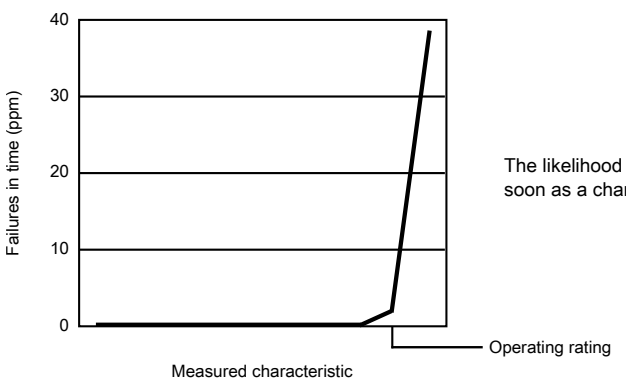
- *Operating ratings* apply during operation of the chip.
- *Handling ratings* apply when the chip is not powered.

5.4.1 Example

This is an example of an operating rating:

Symbol	Description	Min.	Max.	Unit
V_{DD}	1.0 V core supply voltage	–0.3	1.2	V

5.5 Result of exceeding a rating



The likelihood of permanent chip failure increases rapidly as soon as a characteristic begins to exceed one of its operating ratings.

Table 5. Absolute Maximum Ratings (V_{SS} = 0 V, V_{SSA} = 0 V) (continued)

Characteristic	Symbol	Notes[1]	Min	Max	Unit
ADC High Voltage Reference	V_{REFHx}		-0.3	4.0	V
Voltage difference V_{DD} to V_{DDA}	ΔV_{DD}		-0.3	0.3	V
Voltage difference V_{SS} to V_{SSA}	ΔV_{SS}		-0.3	0.3	V
Digital Input Voltage Range	V_{IN}	Pin Group 1	-0.3	5.5	V
$\overline{\text{RESET}}$ Input Voltage Range	V_{IN_RESET}	Pin Group 2	-0.3	4.0	V
Oscillator Input Voltage Range	V_{OSC}	Pin Group 4	-0.4	4.0	V
Analog Input Voltage Range	V_{INA}	Pin Group 3	-0.3	4.0	V
Input clamp current, per pin (V_{IN} < V_{SS} - 0.3 V)[2, 3]	V_{IC}		—	-5.0	mA
Output clamp current, per pin[4]	V_{OC}		—	±20.0	mA
Contiguous pin DC injection current—regional limit sum of 16 contiguous pins	I_{ICont}		-25	25	mA
Output Voltage Range (normal push-pull mode)	V_{OUT}	Pin Group 1, 2	-0.3	4.0	V
Output Voltage Range (open drain mode)	V_{OUTOD}	Pin Group 1	-0.3	5.5	V
$\overline{\text{RESET}}$ Output Voltage Range	V_{OUTOD_RESET}	Pin Group 2	-0.3	4.0	V
DAC Output Voltage Range	V_{OUT_DAC}	Pin Group 5	-0.3	4.0	V
Ambient Temperature	T_A	V temperature	-40	105	°C
		M temperature	-40	125	
Junction Temperature	T_j	V temperature	-40	115	°C
		M temperature	-40	135	°C
Storage Temperature Range (Extended Industrial)	T_{STG}		-55	150	°C

1. **Default Mode**
   - Pin Group 1: GPIO, TDI, TDO, TMS, TCK
   - Pin Group 2: $\overline{\text{RESET}}$
   - Pin Group 3: ADC and Comparator Analog Inputs
   - Pin Group 4: XTAL, EXTAL
   - Pin Group 5: DAC analog output
2. Continuous clamp current
3. All 5 volt tolerant digital I/O pins are internally clamped to V_{SS} through a ESD protection diode. There is no diode connection to V_{DD}. If V_{IN} greater than VDIO_MIN (= V_{SS}–0.3 V) is observed, then there is no need to provide current limiting resistors at the pads. If this limit cannot be observed, then a current limiting resistor is required.
4. I/O is configured as push-pull mode.

7 General

7.1 General characteristics

The device is fabricated in high-density, low-power CMOS with 5 V–tolerant TTL-compatible digital inputs, except for the $\overline{\text{RESET}}$ pin which is 3.3V only. The term “5 V–tolerant” refers to the capability of an I/O pin, built on a 3.3 V–compatible process technology, to withstand a voltage up to 5.5 V without damaging the device.

5 V–tolerant I/O is desirable because many systems have a mixture of devices designed for 3.3 V and 5 V power supplies. In such systems, a bus may carry both 3.3 V– and 5 V–compatible I/O voltage levels (a standard 3.3 V I/O is designed to receive a maximum voltage of 3.3 V ± 10% during normal operation without causing damage). This 5 V–tolerant capability therefore offers the power savings of 3.3 V I/O levels combined with the ability to receive 5 V levels without damage.

Absolute maximum ratings in Table 5 are stress ratings only, and functional operation at the maximum is not guaranteed. Stress beyond these ratings may affect device reliability or cause permanent damage to the device.

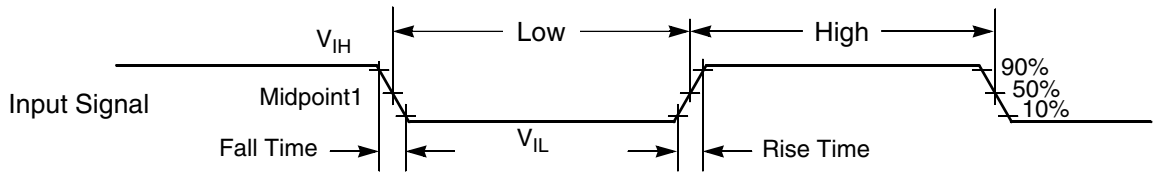
Unless otherwise stated, all specifications within this chapter apply to the temperature range specified in Table 5 over the following supply ranges: V_{SS}=V_{SSA}=0V, V_{DD}=V_{DDA}=3.0V to 3.6V, CL≤50 pF, f_{OP}=50MHz.

CAUTION

This device contains protective circuitry to guard against damage due to high static voltage or electrical fields. However, normal precautions are advised to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate voltage level.

7.2 AC electrical characteristics

Tests are conducted using the input levels specified in Table 8. Unless otherwise specified, propagation delays are measured from the 50% to the 50% point, and rise and fall times are measured between the 10% and 90% points, as shown in Figure 3.



The midpoint is $V_{IL} + (V_{IH} - V_{IL})/2$.

Figure 3. Input signal measurement references

Figure 4 shows the definitions of the following signal states:

- Active state, when a bus or signal is driven, and enters a low impedance state
- Tri-stated, when a bus or signal is placed in a high impedance state
- Data Valid state, when a signal level has reached V_{OL} or V_{OH}
- Data Invalid state, when a signal level is in transition between V_{OL} and V_{OH}

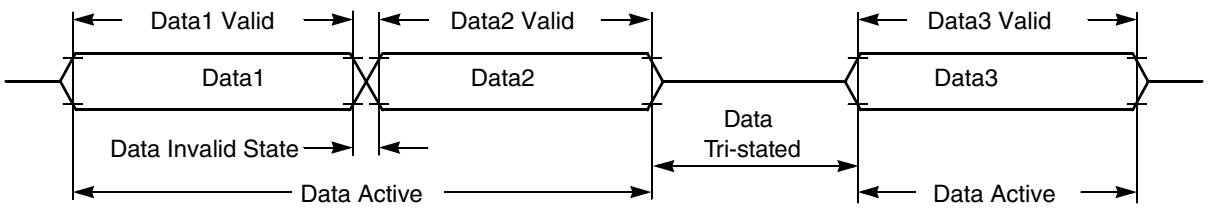


Figure 4. Signal states

7.3 Nonswitching electrical specifications

7.3.1 Voltage and current operating requirements

This section includes information about recommended operating conditions.

NOTE

Recommended V_{DD} ramp rate is between 1 ms and 200 ms.

Table 6. Recommended Operating Conditions (V_{REFLx}=0V, V_{SSA}=0V, V_{SS}=0V)

Characteristic	Symbol	Notes[1]	Min	Typ	Max	Unit
Supply voltage	V_{DD}, V_{DDA}		2.7	3.3	3.6	V
ADC (Cyclic) Reference Voltage High	V_{REFHA} V_{REFHB}		V_{DDA}-0.6		V_{DDA}	V
Voltage difference V_{DD} to V_{DDA}	ΔVDD		-0.1	0	0.1	V
Voltage difference V_{SS} to V_{SSA}	ΔVSS		-0.1	0	0.1	V
Input Voltage High (digital inputs)	V_{IH}	Pin Group 1	0.7 x V_{DD}		5.5	V
$\overline{\text{RESET}}$ Voltage High	V_{IH_RESET}	Pin Group 2	0.7 x V_{DD}	—	V_{DD}	V

Table continues on the next page...

2. Determined according to JEDEC Standard JESD51-6, *Integrated Circuits Thermal Test Method Environmental Conditions —Forced Convection (Moving Air)* with the board horizontal.

8 Peripheral operating requirements and behaviors

8.1 Core modules

8.1.1 JTAG timing

Table 16. JTAG timing

Characteristic	Symbol	Min	Max	Unit	See Figure
TCK frequency of operation	f_{OP}	DC	SYS_CLK/ 8	MHz	Figure 5
TCK clock pulse width	t_{PW}	50	—	ns	Figure 5
TMS, TDI data set-up time	t_{DS}	5	—	ns	Figure 6
TMS, TDI data hold time	t_{DH}	5	—	ns	Figure 6
TCK low to TDO data valid	t_{DV}	—	30	ns	Figure 6
TCK low to TDO tri-state	t_{TS}	—	30	ns	Figure 6

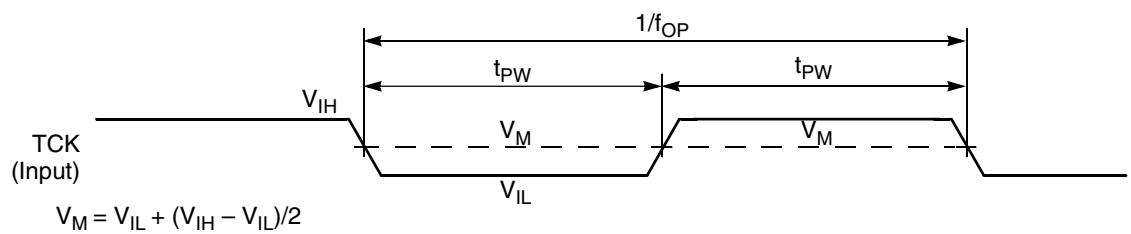


Figure 5. Test clock input timing diagram

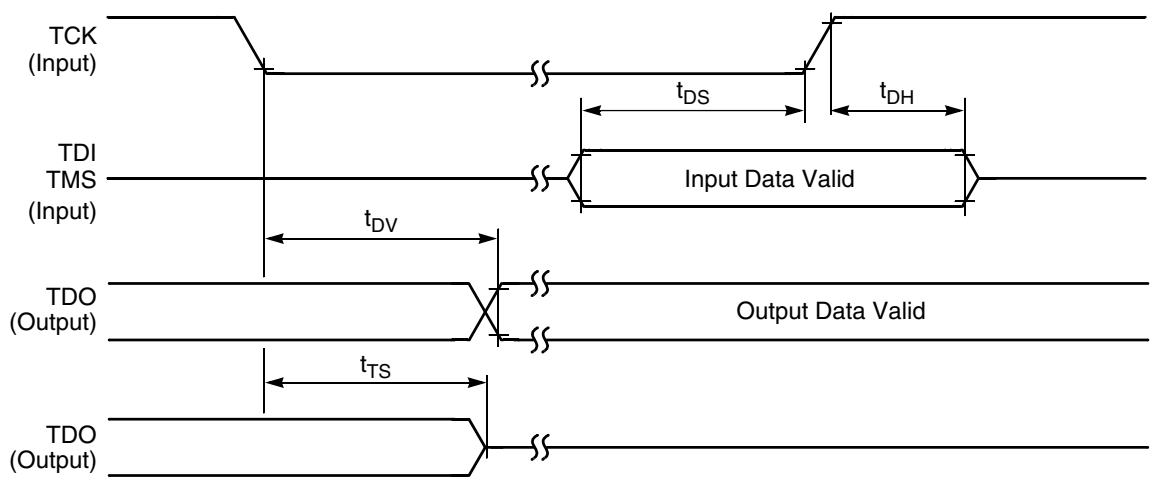


Figure 6. Test access port timing diagram

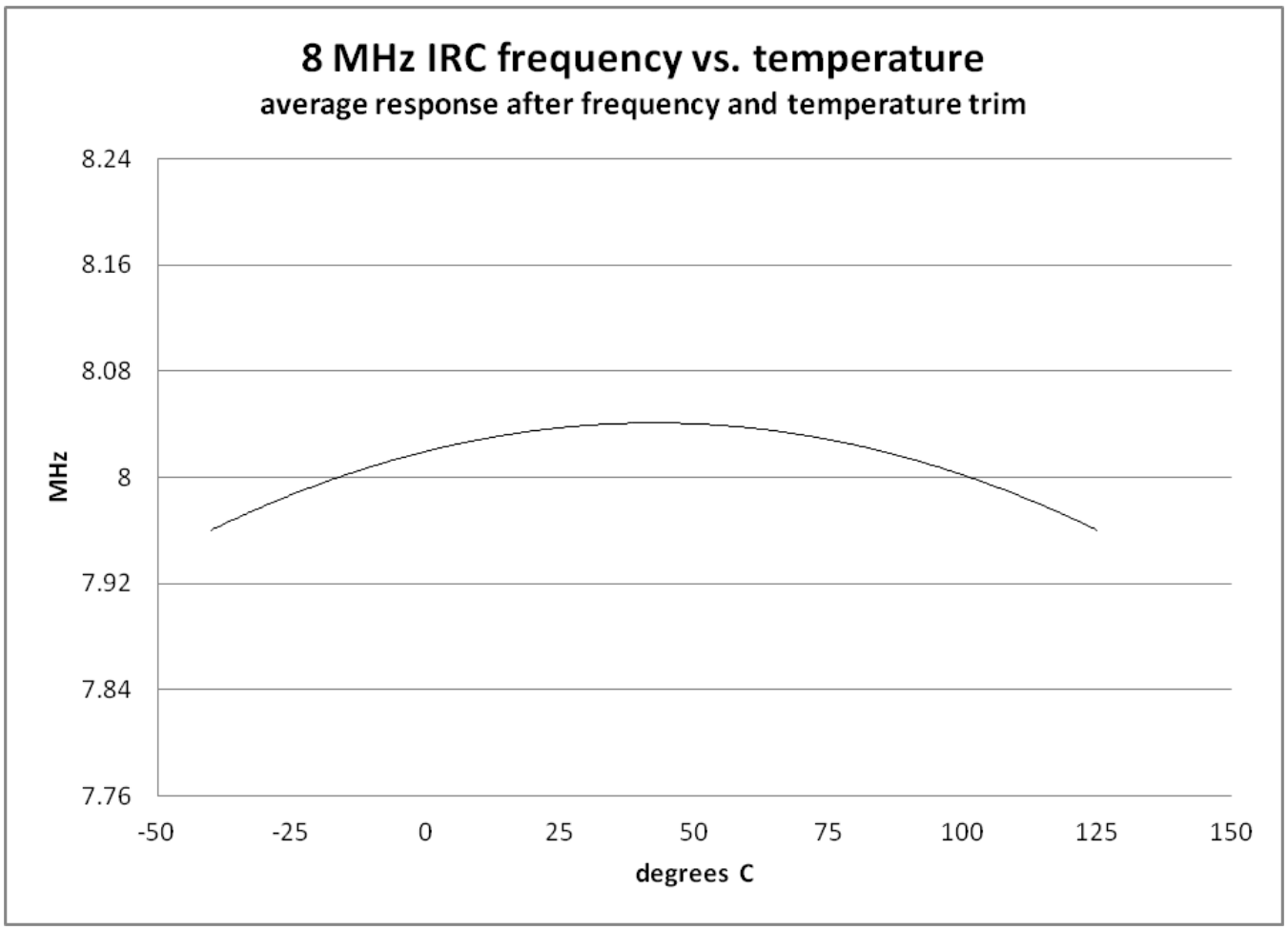


Figure 8. Relaxation Oscillator Temperature Variation (Typical) After Trim (Preliminary)

8.4 Memories and memory interfaces

8.4.1 Flash electrical specifications

This section describes the electrical characteristics of the flash memory module.

8.4.1.1 Flash timing specifications — program and erase

The following specifications represent the amount of time the internal charge pumps are active and do not include command overhead.

Table 23. NVM program/erase timing specifications

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
t_{hvpgm4}	Longword Program high-voltage time	—	7.5	18	µs	—

Table continues on the next page...

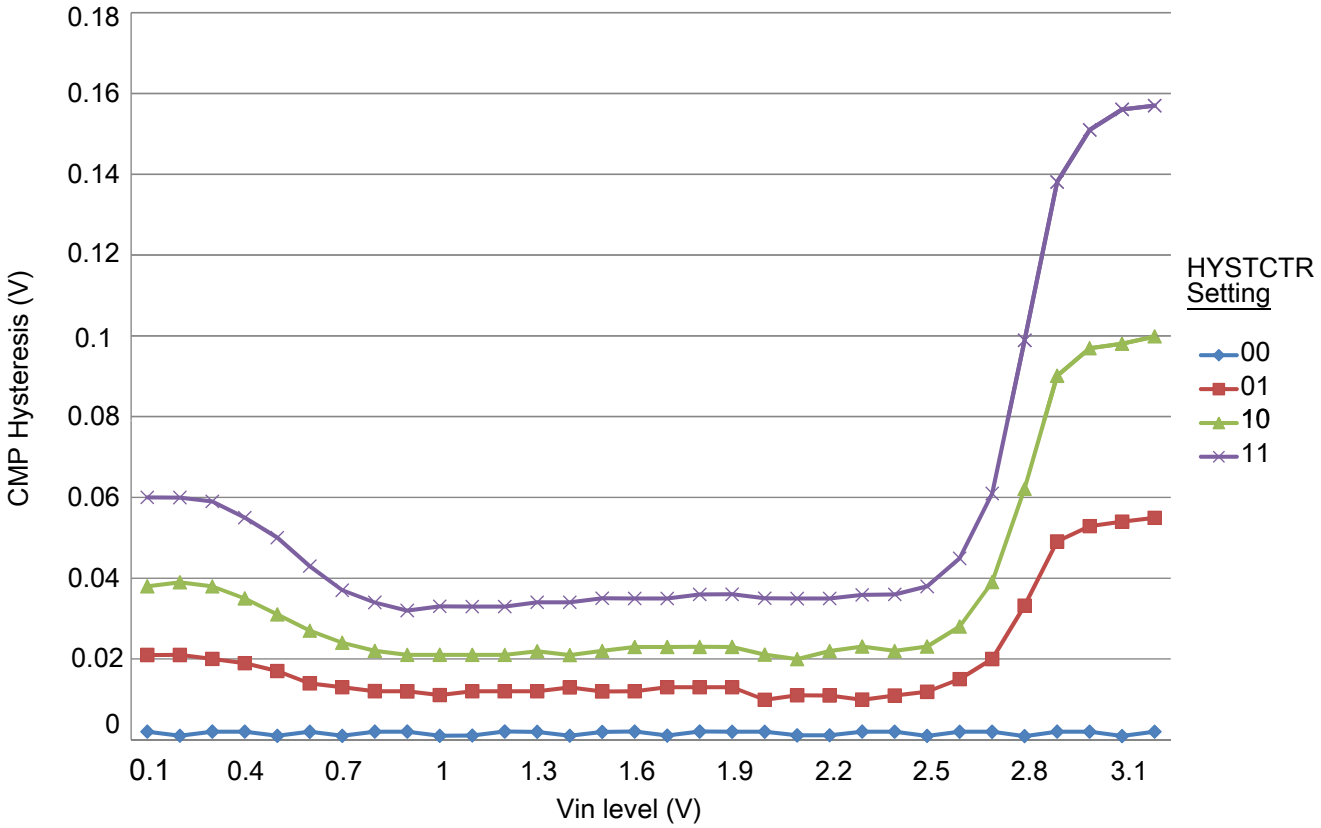


Figure 11. Typical hysteresis vs. Vin level (V_{DD} = 3.3 V, PMODE = 1)

8.6 PWMs and timers

8.6.1 Enhanced NanoEdge PWM characteristics

Table 30. NanoEdge PWM timing parameters

Characteristic	Symbol	Min	Typ	Max	Unit
PWM clock frequency			100		MHz
NanoEdge Placement (NEP) Step Size[1, 2]	pwmp		312		ps
Delay for fault input activating to PWM output deactivated		1			ns
Power-up Time[3]	t_{pu}		25		µs

1. Reference IPbus clock of 100 MHz in NanoEdge Placement mode.
2. Temperature and voltage variations do not affect NanoEdge Placement step size.
3. Powerdown to NanoEdge mode transition.

8.6.2 Quad Timer timing

Parameters listed are guaranteed by design.

Table 31. Timer timing

Characteristic	Symbol	Min[1]	Max	Unit	See Figure
Timer input period	P_{IN}	2T + 6	—	ns	Figure 12
Timer input high/low period	P_{INHL}	1T + 3	—	ns	Figure 12
Timer output period	P_{OUT}	2T-2	—	ns	Figure 12
Timer output high/low period	P_{OUTHL}	1T-2	—	ns	Figure 12

1. T = clock cycle. For 100 MHz operation, T = 10 ns.

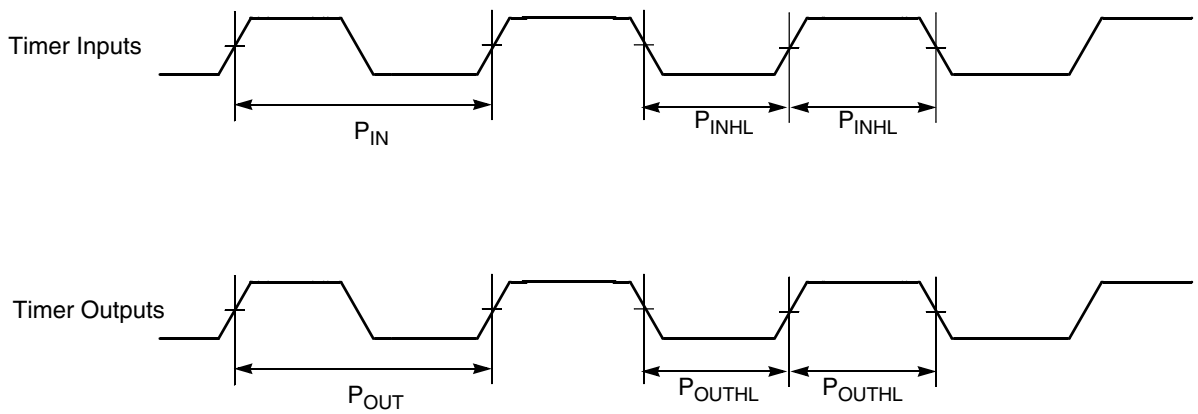


Figure 12. Timer timing

8.7 Communication interfaces

8.7.1 Queued Serial Peripheral Interface (SPI) timing

Parameters listed are guaranteed by design.

Table 32. SPI timing

Characteristic	Symbol	Min	Max	Unit	See Figure
Cycle time Master Slave	t_C	60 60	— —	ns ns	Figure 13 Figure 14 Figure 15 Figure 16
Enable lead time Master Slave	t_{ELD}	— 20	— —	ns ns	Figure 16
Enable lag time Master Slave	t_{ELG}	— 20	— —	ns ns	Figure 16

Table continues on the next page...

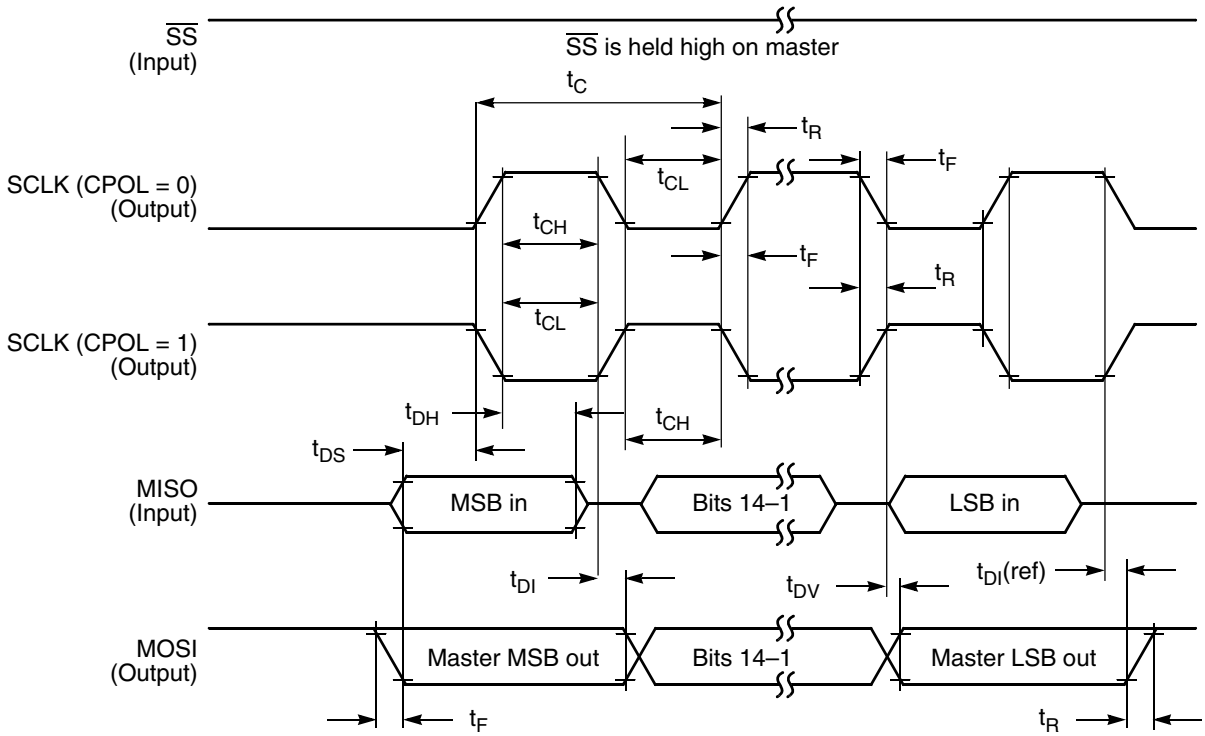


Figure 13. SPI master timing (CPHA = 0)

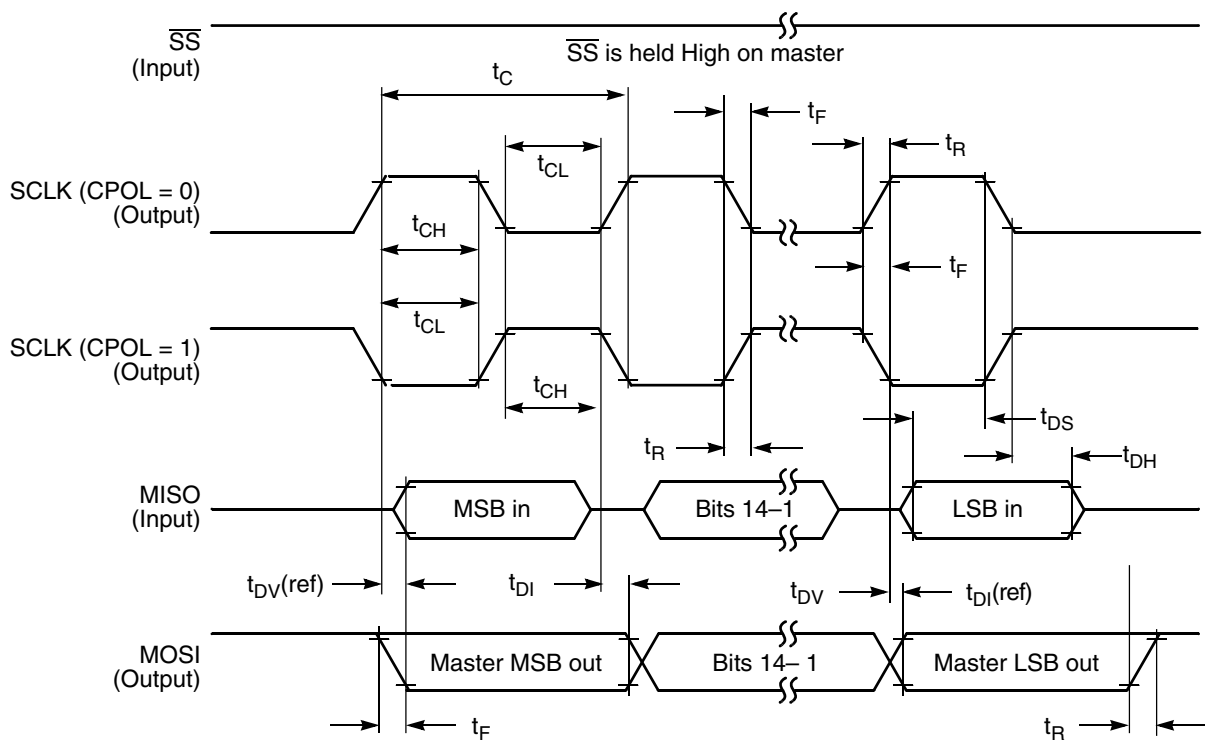


Figure 14. SPI master timing (CPHA = 1)

9.2 Electrical design considerations

CAUTION

This device contains protective circuitry to guard against damage due to high static voltage or electrical fields. However, take normal precautions to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate voltage level.

Use the following list of considerations to assure correct operation of the device:

- Provide a low-impedance path from the board power supply to each V_{DD} pin on the device and from the board ground to each V_{SS} (GND) pin.
- The minimum bypass requirement is to place 0.01–0.1 µF capacitors positioned as near as possible to the package supply pins. The recommended bypass configuration is to place one bypass capacitor on each of the V_{DD}/V_{SS} pairs, including V_{DDA}/V_{SSA}. Ceramic and tantalum capacitors tend to provide better tolerances.
- Ensure that capacitor leads and associated printed circuit traces that connect to the chip V_{DD} and V_{SS} (GND) pins are as short as possible.
- Bypass the V_{DD} and V_{SS} with approximately 100 µF, plus the number of 0.1 µF ceramic capacitors.
- PCB trace lengths should be minimal for high-frequency signals.
- Consider all device loads as well as parasitic capacitance due to PCB traces when calculating capacitance. This is especially critical in systems with higher capacitive loads that could create higher transient currents in the V_{DD} and V_{SS} circuits.
- Take special care to minimize noise levels on the V_{REF}, V_{DDA}, and V_{SSA} pins.
- Using separate power planes for V_{DD} and V_{DDA} and separate ground planes for V_{SS} and V_{SSA} are recommended. Connect the separate analog and digital power and ground planes as near as possible to power supply outputs. If an analog circuit and digital circuit are powered by the same power supply, then connect a small inductor or ferrite bead in serial with V_{DDA}. Traces of V_{SS} and V_{SSA} should be shorted together.
- Physically separate analog components from noisy digital components by ground planes. Do not place an analog trace in parallel with digital traces. Place an analog ground trace around an analog signal trace to isolate it from digital traces.
- Because the flash memory is programmed through the JTAG/EOnCE port, SPI, SCI, or I^2C, the designer should provide an interface to this port if in-circuit flash programming is desired.
- If desired, connect an external RC circuit to the $\overline{\text{RESET}}$ pin. The resistor value should be in the range of 4.7 kΩ–10 kΩ; the capacitor value should be in the range of 0.22 µF–4.7 µF.

high current will be pulled by DSC from the supply, which can cause the supply voltage to drop below the operation voltage; see the captured graph (Figure 22). This can cause the DSC fail to start up.

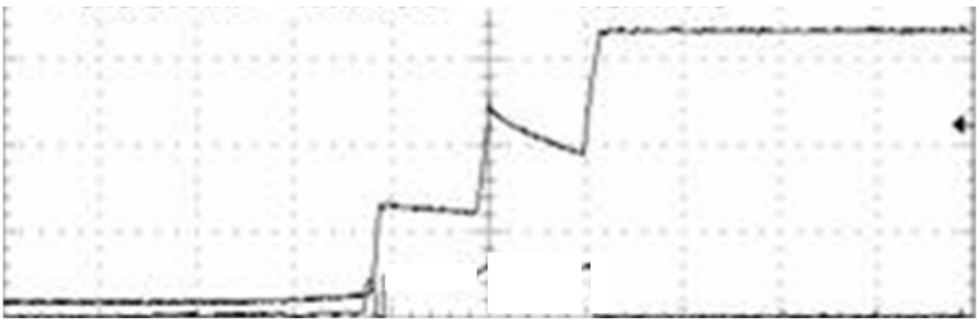


Figure 22. Supply Voltage Drop

A recommended initialization sequence during power-up is:

1. After POR is released, run a few hundred NOP instructions from the internal relaxation oscillator; this gives time for the supply voltage to stabilize.
2. Configure the peripherals (except the ADC) to the desired settings; the ADC should stay in low power mode.
3. Power up the PLL.
4. After the PLL locks, switch the clock from PLL prescale to postscale.
5. Configure the ADC.

10 Obtaining package dimensions

Package dimensions are provided in package drawings.

To find a package drawing, go to **freescale.com** and perform a keyword search for the drawing's document number:

Drawing for package	Document number to be used
32LQFP	98ASH70029A
32QFN	98ASA00473D
48-pin LQFP	98ASH00962A
64-pin LQFP	98ASS23234W

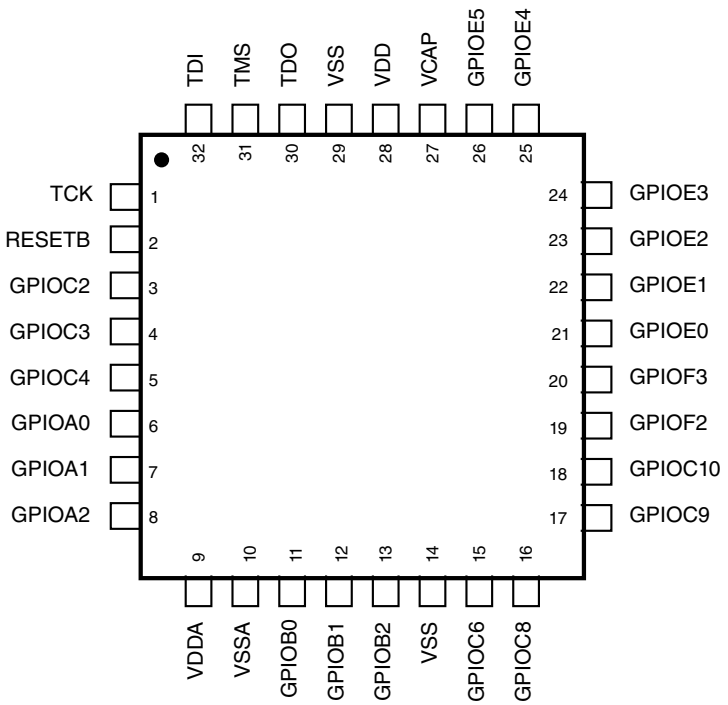


Figure 25. 32-pin LQFP and QFN

NOTE

The RESETB pin is a 3.3 V pin only.

12 Product documentation

The documents listed in Table 36 are required for a complete description and to successfully design using the device. Documentation is available from local NXP distributors, NXP sales offices, or online at **www.nxp.com**.

Table 36. Device documentation

Topic	Description	Document Number
DSP56800E/DSP56800EX Reference Manual	Detailed description of the 56800EX family architecture, 32-bit digital signal controller core processor, and the instruction set	DSP56800ERM
MC56F827xx Reference Manual	Detailed functional description and programming model	MC56F827XXRM
MC56F827xx Data Sheet	Electrical and timing specifications, pin descriptions, and package information (this document)	MC56F827XXDS
MC56F82xxx Errata	Details any chip issues that might be present	MC56F82xxx_Errata